

Application/Control No. 10/540,527	Applicant(s)/Patent under Reexamination INOUE ET AL.
Examiner	Art Unit
John P. Sheehan	1793

		ORIGINAL			INTERNATIONAL CLASSIFICATION									
CLASS SUBCLASS							CL	AIMED		NON-CLAIMED				
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CLASS	SUBCLA	ASS (ONE S	SUBCLASS PE	R BLOCK)					,					
148	104							1			1			
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Claims renumbered in the same order as presented by applicant									□СРА			☐ T.D.			☐ R.1.47				
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	5]		35			65]		95			125			155			185
	6			36			66			96			126			156			186
3	7			37			67			97			127			157			187
4	8			38			68			98			128			158			188
	9			39			69			99			129			159			189
	10			40			70			100			130			160			190
	11			41			71			101			131			161			191
	12]		42			72]		102			132			162			192
	13]		43			73]		103			133			163			193
	14]		44			74]		104			134			164			194
	15	ļ		45			75	ļ		105			135			165			195
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	17]		47			77]		107			137			167			197
	18			48			78			108			138			168			198
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	20			50			80			110			140			170			200
	21	ļ		51			81	ļ		111			141			171			201
	22]		52			82]		112			142			172			202
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	27]		57			87]		117			147			177			207
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